

<b>Notice of References Cited</b>		Application/Control No.	Applicant(s)/Patent Under Reexamination KIRSCH ET AL.	
		Examiner SIMON D. NGUYEN	Art Unit 2685	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,731,911	05-2004	Hirata et al.	455/71
*	B	US-6,639,939	10-2003	Naden et al.	375/140
*	C	US-5,594,754	01-1997	Dohi et al.	375/148
*	D	US-2003/0114110	06-2003	Dahlback et al.	455/67.1
*	E	US-6,289,061	09-2001	Kandala et al.	375/344
*	F	US-2002/0177458	11-2002	Hokao, Tomoaki	455/502
*	G	US-6,933,788	08-2005	Forrester, Tim	331/1R
*	H	US-6,704,555	03-2004	Sih et al.	455/245.1
*	I	US-6,704,552	03-2004	Matsumoto, Mariko	455/164.1
*	J	US-6,571,088	05-2003	Hasegawa, Osamu	455/182.2
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.